

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/646,604	DEBLANC ET AL.
	<b>Examiner</b>	Art Unit
	PHAN T.H. PALMER	2874

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner